

CD4007C

Dual Complementary Pair Plus Inverter

General Description

The CD4007C consists of three complementary pairs of N- and P-channel enhancement mode MOS transistors suitable for series/shunt applications. All inputs are protected from static discharge by diode clamps to V_{DD} and V_{SS} .

For proper operation the voltages at all pins must be constrained to be between $V_{SS} - 0.3V$ and $V_{DD} + 0.3V$ at all times.

Features

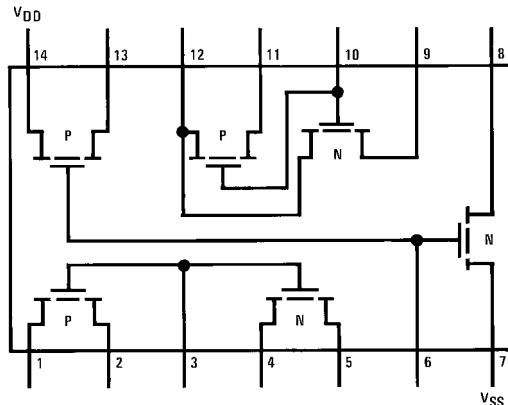
- Wide supply voltage range: 3.0V to 15V
- High noise immunity: 0.45 V_{CC} (typ.)

Ordering Code:

Order Number	Package Number	Package Description
CD4007CM	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow
CD4007CN	N14A	14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Connection Diagram



Note: All P-channel substrates are connected to V_{DD} and all N-channel substrates are connected to V_{SS} .

Top View

Absolute Maximum Ratings(Note 1)

Voltage at Any Pin	V_{SS} -0.3V to V_{DD} +0.3V
Operating Temperature Range	-55°C to +125°C
Storage Temperature Range	-65°C to +150°C
Power Dissipation (P_D)	
Dual-In-Line	700 mW
Small Outline	500 mW
Operating V_{DD} Range	V_{SS} +3.0V to V_{SS} +15V
Lead Temperature (Soldering, 10 seconds)	260°C

Note 1: This device should not be connected to circuits with the power on because high transient voltages may cause permanent damage.

DC Electrical Characteristics

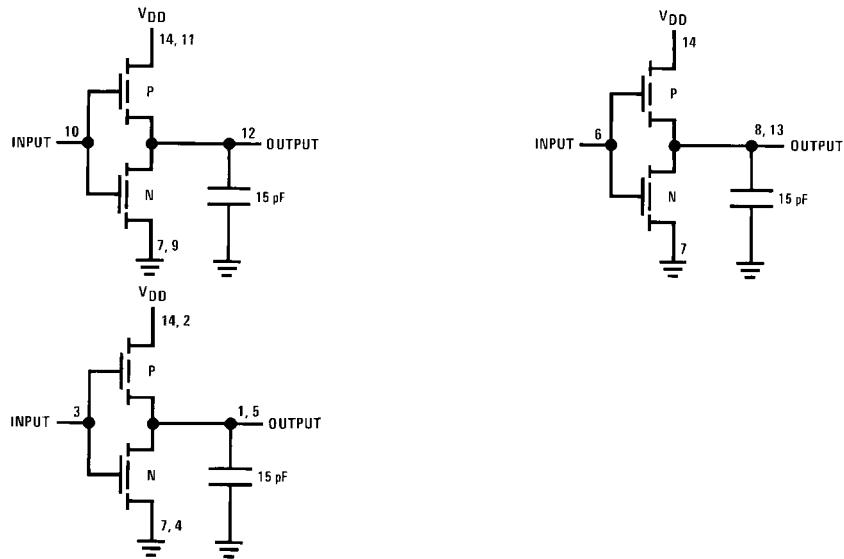
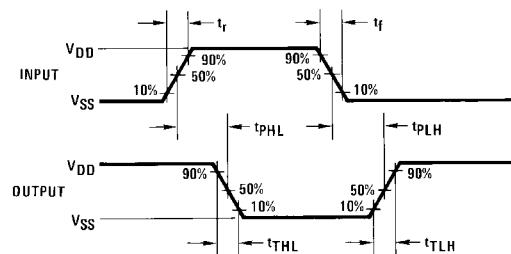
Symbol	Parameter	Conditions	Limits									Units	
			-55°C			+25°C			+125°C				
			Min	Typ	Max	Min	Typ	Max	Min	Typ	Max		
I_L	Quiescent Device Current	$V_{DD} = 5.0V$ $V_{DD} = 10V$			0.05		0.001	0.05			3.0	μA	
					0.1		0.001	1.0			6.0		
P_D	Quiescent Device Dissipation Package	$V_{DD} = 5.0V$ $V_{DD} = 10V$			0.25		0.005	2.5			15	μW	
					1.0		0.001	10			60		
V_{OL}	Output Voltage LOW Level	$V_{DD} = 5.0V$ $V_{DD} = 10V$			0.05		0	0.01			0.05	V	
					0.05		0	0.01			0.05		
V_{OH}	Output Voltage HIGH Level	$V_{DD} = 5.0V$ $V_{DD} = 10V$	4.95			4.95	5.0		4.95			V	
			9.95			9.95	10		9.95				
V_{NL}	Noise Immunity (All inputs)	$V_{DD} = 5.0V$, $V_O = 3.6V$ $V_{DD} = 10V$, $V_O = 7.2V$			1.5		2.25	1.5			1.4	V	
					3.0		4.5	3.0			2.9		
V_{NH}	Noise Immunity (All Inputs)	$V_{DD} = 5.0V$, $V_O = 0.95V$ $V_{DD} = 10V$, $V_O = 2.9V$	3.6			3.5	2.25		3.5			V	
			7.1			7.0	4.5		7.0				
I_{pN}	Output Drive Current N-Channel	$V_{DD} = 5.0V$, $V_O = 0.4V$, $V_I = V_{DD}$ $V_{DD} = 10V$, $V_O = 0.5V$, $V_I = V_{DD}$	0.75			0.6	1.0		0.4			mA	
			1.6			1.3	2.5		0.95				
I_{pP}	Output Drive Current P-Channel	$V_{DD} = 5.0V$, $V_O = 2.5V$, $V_I = V_{SS}$ $V_{DD} = 10V$, $V_O = 9.5V$, $V_I = V_{SS}$	-1.75			-1.4	-4.0		-1.0			mA	
			-1.35			-1.1	-2.5		-0.75				
I_I	Input Current						10					pA	

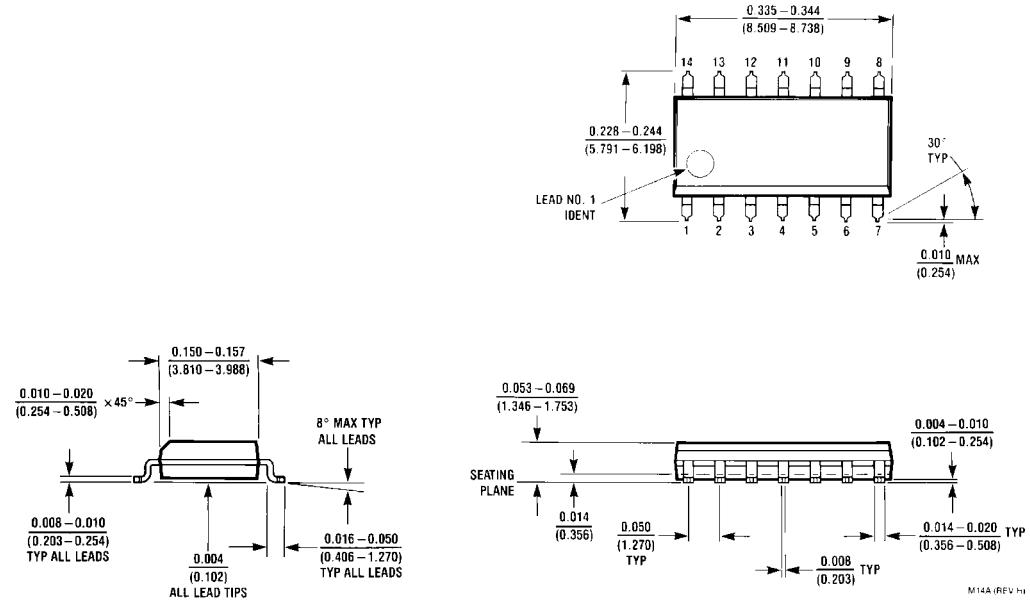
AC Electrical Characteristics (Note 2)

$T_A = 25^\circ C$ and $C_L = 15 \text{ pF}$ and rise and fall times = 20 ns. Typical temperature coefficient for all values of $V_{DD} = 0.3\%/\text{ }^\circ C$

Symbol	Parameter	Conditions	Min	Typ	Max	Units
$t_{PLH} = t_{PHL}$	Propagation Delay Time	$V_{DD} = 5.0V$ $V_{DD} = 10V$		35	75	ns
				20	50	
$t_{TLH} = t_{THL}$	Transition Time	$V_{DD} = 5.0V$ $V_{DD} = 10V$		50	100	ns
				30	50	
C_I	Input Capacitance	Any Input		5		pF

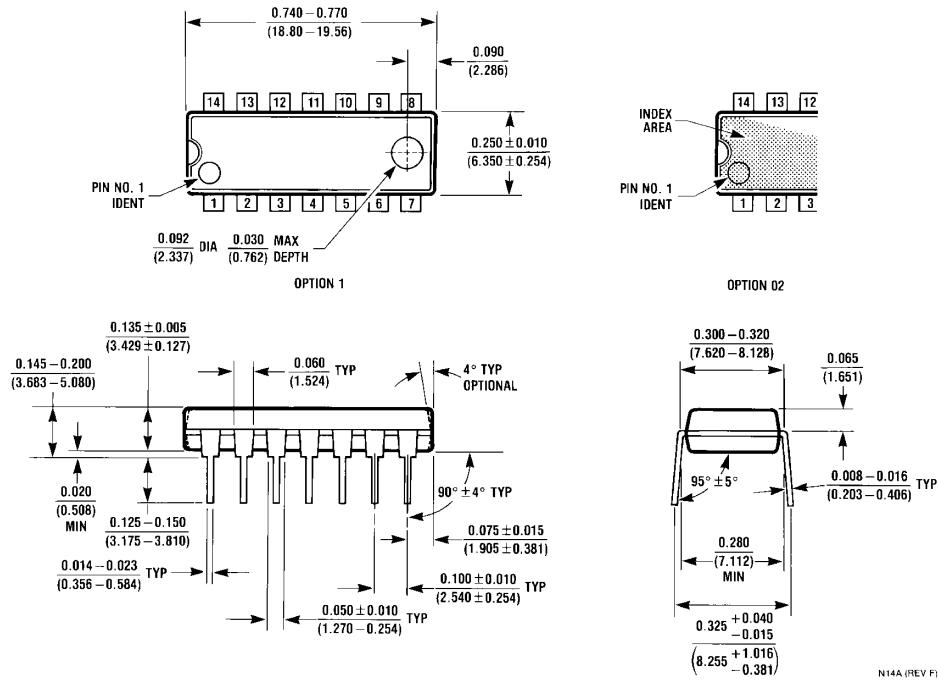
Note 2: AC Parameters are guaranteed by DC correlated testing.

AC Test Circuits**Switching Time Waveforms**

Physical Dimensions inches (millimeters) unless otherwise noted

14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow
Package Number M14A

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide
Package Number N14A

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